



 $16950 \ \ Semiconductor \ component \ checker \ \& \ curve \ tracer \ are \ useful \ for \ checking \ \& \ tracing \ the \ characteristics \ curve \ of \ a \ variety \ of \ components \ in \ a \ very \ short \ time \ duration. \ The \ Instrument \ consist \ of \ five \ different \ sections, \ detail \ Specifications \ \& \ features \ are \ following:$

SECTION - 1. DIODE CHECKER:

SPECIFICATIONS:

01. Indicates whether diode is open circuit, short circuit & if working, its polarity.

02. Silicon & germanium, both types of diodes can be tested.

FEATURES:

Two LED's & One test switch are provided showing:

01. Open diode - If both LED's are OFF.

02. Short diode - If both LED's are ON.

03. Good diode - If one glows fully & other dim.

SECTION - 2. TRANSISTOR CHECKER:-

SPECIFICATIONS:

 $01. \hspace{1.5cm} \hbox{For good transistor LED marked GOOD will glow}.$

02. For bad transistor LED marked BAD will glow..

FEATURES:

01. One transistor socket and three sockets are provided.

02. A switch decides NPN or PNP transistor.

03. Good transistor - If one glows fully & other dim.

SECTION - 3. FET CHECKER: -

SPECIFICATIONS:

01. For GOOD FET, the meter needle vibrates continuously between a maximum position to a minimum position.

For BAD FET, either there is no response in the meter or it holds at one point.

FEATURES:

01. One transistor socket and three sockets are provided.

02. An ammeter of 1 mA range is provided.

03. Designed to test almost all FET's.

SECTION - 4. TRANSISTOR PARAMETER CHECKER: SPECIFICATIONS:

TRANSISTOR TESTER TESTS I LEAKAGE AND GAIN CBO AT TWO RANGES LOW AND HIGH.

Icbo TEST : 0 to 15 mA on LOW range. 0 to 50mA on HIGH

range.

LEAKAGETEST: 0 to 500 mA on LOW range. 0 to 1500mA on

HIGH range.

GAINTEST: 0 to 50 mA on LOW range. 0 to 150mA on HIGH

range for values of base current i.e. 300, 150, 50,

and 25mA.

Note: Specifications are subject to change.

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FEATURES:

- 01. Big 115 mm X 55 mm (4.5" X 2.25") dial of meter increases the accuracy of readings.
- Four values of base current are provided for gain measurement so that gain can be compared under four conditions.
- A six position selector switch selects gain at 300, 150, 50, and 25mA base current, leakage and I currents.
- 04. Another switch selects HIGH and LOW rangs.
- 05. A transistor socket is provided for transistors with short leads, and three sockets for any other.
- A PNP NPN switch selects PNP or NPN transistor to be checked.

SECTION - 5. CURVE TRACER :-

SPECIFICATIONS:

Semiconductor Device range:

- 01. Bipolar Transistor (NPN & PNP)
- 02. FET (Juction N & PType)
- 03. SCR
- 04. UJT (N-Channel)
- 05. ZENER DIODE (Upto 50V Vz)
- 06. GERMANIUM & SILICON DIODES
- 07. LED

FEATURES:

- 01. Full protection of semi-conductor devices.
- 02. Full protection of internal circuitry.
- 03. Selection of Forward or Reverse characteristics for Zener diodes, diodes & LED by a switch.
- 04. Ease of operation due to minimum number of panel settings.

COMMON FEATURES: -

- For connecting devices two Nos. of 3 test cables are provided.
- Power Requirement : 230 V \pm 10% at 50 Hz A.C. mains.
- Strongly supported by detailed operating instractions.
- Weight: 4 Kg. (Approx)
- Dimension: W 340 x H 110 x D 210.

OTHER APPARATUS REQUIRED:

• Cathod Ray Oscilloscape